

# 1Mb SYNCBURST<sup>™</sup> SRAM

# MT58L64L18P, MT58L32L32P, MT58L32L36P

3.3V VDD, 3.3V I/O, Pipelined, Single-Cycle Deselect

## FEATURES

- Fast clock and OE# access times
- Single +3.3V +0.3V/-0.165V power supply (VDD)
- Separate +3.3V +0.3V/-0.165V isolated output buffer supply (VDDQ)
- SNOOZE MODE for reduced-power standby
- Single-cycle deselect (Pentium<sup>®</sup> BSRAMcompatible)
- Common data inputs and data outputs
- Individual BYTE WRITE control and GLOBAL WRITE
- Three chip enables for simple depth expansion and address pipelining
- Clock-controlled and registered addresses, data I/Os and control signals
- Internally self-timed WRITE cycle
- Burst control pin (interleaved or linear burst)
- Automatic power-down for portable applications
- 100-lead TQFP for high density, high speed
- Low capacitive bus loading

**OPTIONS** 

• x18, x32 and x36 options available

#### MARKING

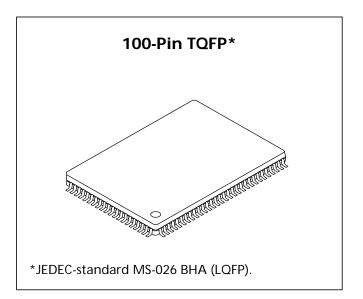
<ul> <li>Timing (Access/Cycle/MHz)</li> </ul>	
3.5ns/6.0ns/166 MHz	-6
4.2ns/7.5ns/133 MHz	-7.5
5ns/10ns/100 MHz	-10
<ul> <li>Configurations</li> </ul>	
64K x 18	MT58L64L18P
32K x 32	MT58L32L32P
32K x 36	MT58L32L36P
Package	
100-pin TQFP	Т
Operating Temperature Range	
Commercial (0°C to +70°C)	None
Industrial (-40°C to +85°C)	IT
Part Number Example:	

# MT58L64L18PT-10 IT

#### **GENERAL DESCRIPTION**

The Micron<sup>®</sup> SyncBurst<sup>™</sup> SRAM family employs high-speed, low-power CMOS designs that are fabricated using an advanced CMOS process.

The MT58L64L18P and MT58L32L32/36P 1Mb SRAMs integrate a 64K x 18, 32K x 32, or 32K x 36 SRAM core with advanced synchronous peripheral circuitry and a 2-bit burst counter. All synchronous inputs pass



through registers controlled by a positive-edge-triggered single clock input (CLK). The synchronous inputs include all addresses, all data inputs, active LOW chip enable (CE#), two additional chip enables for easy depth expansion (CE2, CE2#), burst control inputs (ADSC#, ADSP#, ADV#), byte write enables (BWx#) and global write (GW#).

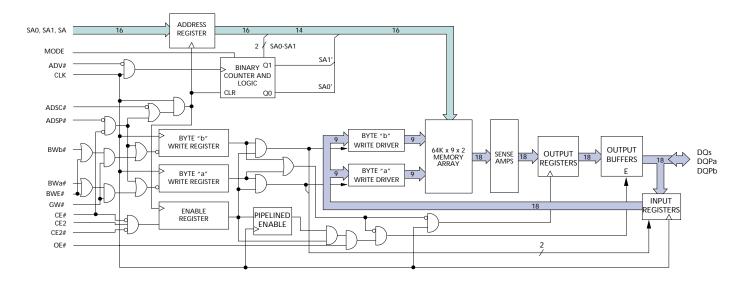
Asynchronous inputs include the output enable (OE#), clock (CLK) and snooze enable (ZZ). There is also a burst mode pin (MODE) that selects between interleaved and linear burst modes. The data-out (Q), enabled by OE#, is also asynchronous. WRITE cycles can be from one to two bytes wide (x18) or from one to four bytes wide (x32/x36), as controlled by the write control inputs.

Burst operation can be initiated with either address status processor (ADSP#) or address status controller (ADSC#) input pins. Subsequent burst addresses can be internally generated as controlled by the burst advance pin (ADV#).

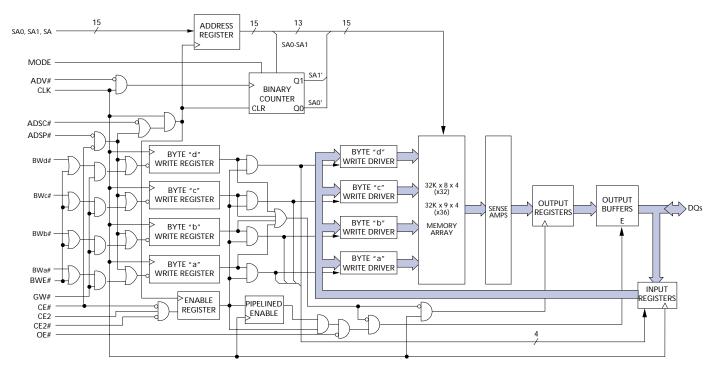
Address and write control are registered on-chip to simplify WRITE cycles. This allows self-timed WRITE cycles. Individual byte enables allow individual bytes to be written. During WRITE cycles on the x18 device, BWa# controls DQa pins and DQPa; BWb# controls DQb pins and DQPb. During WRITE cycles on the x32 and x36 devices, BWa# controls DQa pins and DQPa; BWb# controls DQb pins and DQPb; BWc# controls



#### FUNCTIONAL BLOCK DIAGRAM 64K x 18



## FUNCTIONAL BLOCK DIAGRAM 32K x 32/36



# **NOTE:** Functional Block Diagrams illustrate simplified device operation. See Truth Table, Pin Descriptions and timing diagrams for detailed information.



#### **GENERAL DESCRIPTION (continued)**

DQc pins and DQPc; BWd# controls DQd pins and DQPd. GW# LOW causes all bytes to be written. Parity pins are only available on the x18 and x36 versions.

This device incorporates a single-cycle deselect feature during READ cycles. If the device is immediately deselected after a READ cycle, the output bus goes to a High-Z state <sup>t</sup>KQHZ nanoseconds after the rising edge of clock.

Micron's 1Mb SyncBurst SRAMs operate from a +3.3V power supply, and all inputs and outputs are

TTL-compatible. The device is ideally suited for Pentium and PowerPC pipelined systems and systems that benefit from a very wide, high-speed data bus. The device is also ideal in generic 16-, 18-, 32-, 36-, 64- and 72-bitwide applications.

Please refer to the Micron Web site (<u>www.micron.com/mti/msp/html/sramprod.html</u>) for the latest data sheet.

x18

NC

NC

SA

Vss

VddQ

SA

SA ADV#

ADSP#

ADSC#

OE#

BWE#

GW#

CLK

Vss

Vdd

CE2#

BWa#

BWb#

CE2

CE#

SA

SA

BWc#

BWd#

NC

NC

x32/x36

DQb

DQb

NC/DQPb\*\*

PIN #x18x32/x361NCNC/DQPc**2NCDQC3NCDQC3NCDQC4 $VodQ$ 29NCDQd5 $Vss$ 30NCNC/DQPd**6NCDQC31MODE7NCDQC32SA8DQbDQC33SA9DQbDQC33SA9DQbDQC33SA11 $Vddddddddddddddddddddddddddddddddddd$			·	 								
2NCDQc3NCDQc4 $V_{DDQ}$ 5 $V_{SS}$ 6NCDQc7NCDQc8DQbDQc10 $V_{SS}$ 11 $V_{DDQ}$ 12DQbDQc13DQbDQc14 $V_{DD}$ 15 $V_{DD}$ 16NC1117 $V_{SS}$ 18DQbDQd19DQbDQd10 $V_{SS}$ 16NC17 $V_{SS}$ 18DQbDQd21 $V_{SS}$ 22DQb23DQb24DQb25<	PIN #	x18	x32/x36	PIN #	x18	x32/x36	PIN #	x18	x32/x36	PIN #		
3NCDQc4 $VodQ$ 28NCDQd5 $Vss$ 30NC $DQd$ 6NCDQc30NC $NC/DQP4^{**}$ 6NCDQc32SA7NCDQc33SA9DQbDQc34SA10 $Vss$ 35SA11 $VodQ$ 36SA112DQbDQc38DNU16NC41 $Vod$ 17 $Vss$ 42DNU18DQbDQd44SA20 $VodQ$ 45SA21 $Vss$ 46SA22DQbDQd48SA23DQbDQd49 $NC/SA^*$	1	NC	NC/DQPc**	26	١	/ss	51	NC	NC/DQPa**	76		
$4$ $V_{DDQ}$ $29$ $NC$ $DQd$ $5$ $V_{SS}$ $30$ $NC$ $NC/DQPd^{**}$ $6$ $NC$ $DQc$ $31$ $MODE$ $7$ $NC$ $DQc$ $32$ $SA$ $8$ $DQb$ $DQc$ $33$ $SA$ $9$ $DQb$ $DQc$ $34$ $SA$ $10$ $V_{SS}$ $35$ $SA$ $11$ $V_{DDQ}$ $36$ $SA1$ $12$ $DQb$ $DQc$ $37$ $SA0$ $14$ $V_{DD}$ $39$ $DNU$ $16$ $NC$ $41$ $V_{DD}$ $17$ $V_{SS}$ $42$ $DNU$ $18$ $DQb$ $DQd$ $20$ $V_{DQQ}$ $45$ $SA$ $21$ $V_{SS}$ $46$ $SA$ $22$ $DQb$ $DQd$ $23$ $DQb$ $DQd$ $24$ $DQPb$ $DQd$	2	NC	DQc	27	VddQ		52	NC	DQa	77		
5 $V_{SS}$ 30NCNC/DQPd**6NCDQc31MODE7NCDQc32SA8DQbDQc33SA9DQbDQc34SA10Vss35SA11VbbQ36SA112DQbDQc37SA013DQbDQc38DNU14Vbb39DNU15Vbb40Vss16NC41Vbb17Vss42DNU18DQbDQd21Vss4622DQbDQd23DQbDQd24DQPbDQd24DQPbDQd	3	NC	DQc	28	NC	DQd	53	NC	DQa	78		
6NCDQc7NCDQc8DQbDQc9DQbDQc10Vss11VDDQ12DQbDQc13DQbDQc14VDD15VDD16NC17Vss18DQbDQd20VDDQ21Vss22DQbDQd23DQbDQd24DQbDQd44SA49NC/SA*	4	Vc	DD	29	NC	DQd	54	VD	DQ	79		
7NCDQc8DQbDQc9DQbDQc10Vss11VDDQ12DQbDQc13DQbDQc14VDD15VDD16NC17Vss18DQbDQd20VDDQ21Vss22DQbDQd23DQbDQd24DQbDQd44SA49NC/SA*	5	V	ss	30	NC	NC/DQPd**	55	V	SS	80		
8DQbDQc9DQbDQc10Vss11VDDQ12DQbDQc13DQbDQc14VDD15VDD16NC17Vss18DQbDQd19DQbDQd21Vss22DQbDQd23DQbDQd24DQbDQd44SA73DQa74DQb74DQb74DQb74DQb74DQb	6	NC	DQc	31	M	ODE	56	NC	DQa	81		
9DQbDQc10 $V_{SS}$ 34SA11 $V_{DDQ}$ 35SA12DQbDQc37SAO13DQbDQc38DNU14 $V_{DD}$ 39DNU15 $V_{DD}$ 40 $V_{SS}$ 16NC41 $V_{DD}$ 17 $V_{SS}$ 42DNU18DQbDQd20 $V_{DDQ}$ 45SA21 $V_{SS}$ 46SA22DQbDQd23DQbDQd24DQPbDQd24DQPbDQd	7	NC	DQc	32		SA	-	NC	DQa	82		
10 $V_{SS}$ 35 $SA$ 60 $V_{SS}$ 11 $V_{DDQ}$ 36 $SA1$ 61 $V_{DDQ}$ 12 $DQb$ $DQc$ 37 $SA0$ 62 $DQa$ 13 $DQb$ $DQc$ 38 $DNU$ 63 $DQa$ 14 $V_{DD}$ 39 $DNU$ 64 $ZZ$ 15 $V_{DD}$ 40 $V_{SS}$ 66 $NC$ 16 $NC$ 41 $V_{DD}$ 66 $NC$ 17 $V_{SS}$ 42 $DNU$ 67 $V_{SS}$ 18 $DQb$ $DQd$ 44 $SA$ 69 $DQa$ 20 $V_{DDQ}$ 45 $SA$ 70 $V_{DDQ}$ 21 $V_{SS}$ 46 $SA$ 71 $V_{SS}$ 22 $DQb$ $DQd$ 48 $SA$ 72 $DQa$ 23 $DQb$ $DQd$ 49 $NC/SA^*$ 74 $DQPa$	8	DQb	DQc	33		SA	58	D	Qa	83		
11 $V_{DDQ}$ 36SA161 $V_{DDQ}$ 12DQbDQc37SA062DQa13DQbDQc38DNU63DQa14 $V_{DD}$ 39DNU64ZZ15 $V_{DD}$ 40 $V_{SS}$ 65 $V_{DD}$ 16NC41 $V_{DD}$ 66NC17 $V_{SS}$ 42DNU67 $V_{SS}$ 18DQbDQd44SA69DQa20 $V_{DDQ}$ 45SA70 $V_{DDQ}$ 21 $V_{SS}$ 46SA71 $V_{SS}$ 22DQbDQd48SA72DQa23DQbDQd49NC/SA*74DQPa	9	DQb	DQc	34	0	SA	59	D	Qa	84		
12DQbDQc13DQbDQc14 $V_{DD}$ 15 $V_{DD}$ 16NC17 $V_{SS}$ 18DQbDQd19DQbDQd20 $V_{DDQ}$ 21 $V_{SS}$ 22DQbDQd23DQbDQd24DQPbDQd44SA49NC/SA*60NC61NC62DQa63DQa64ZZ65 $V_{DD}$ 66NC67 $V_{SS}$ 70 $V_{DDQ}$ 71 $V_{SS}$ 72DQa73DQa74DQPa74DQPa	10	V	'ss	35	SA		60	0 Vss		85		
$ \begin{array}{c c c c c c c c c c c c c c c c c c c $	11	Vc	DD	36	SA1		SA1		61	VddQ		86
$ \begin{array}{c c c c c c c c c c c c c c c c c c c $	12	DQb	DQc	37	SA0		62	DQa		87		
$ \begin{array}{c c c c c c c c c c c c c c c c c c c $	13	DQb	DQc	38	D	NU	63	DQa		88		
$ \begin{array}{c c c c c c c c c c c c c c c c c c c $	14	V	DD	39	DNU		DNU		64	Z	Z	89
$ \begin{array}{c c c c c c c c c c c c c c c c c c c $	15	V	DD	40	Vss		65	V	DD	90		
18         DQb         DQd           19         DQb         DQd           20         VDDQ           21         VSS           22         DQb         DQd           23         DQb         DQd           24         DQPb         DQd           49         NC/SA*	16	Ν	IC	41	V	/DD	66	N	IC	91		
$ \begin{array}{c c c c c c c c c c c c c c c c c c c $	17	٧	'ss	42	D	NU	67	V	'ss	92		
20         VDDQ         45         SA         70         VDDQ           21         Vss         46         SA         71         Vss           22         DQb         DQd         47         SA         72         DQa         DQb           23         DQb         DQd         48         SA         73         DQa         DQb           24         DQPb         DQd         49         NC/SA*         74         DQPa         DQb	18	DQb	DQd	43	D	NU	68	DQa	DQb	93		
21         Vss         46         SA         71         Vss           22         DQb         DQd         47         SA         72         DQa         DQb           23         DQb         DQd         48         SA         73         DQa         DQb           24         DQPb         DQd         49         NC/SA*         74         DQPa         DQb	19	DQb	DQd	44	0	SA	69	DQa	DQb	94		
22         DQb         DQd         47         SA         72         DQa         DQb           23         DQb         DQd         48         SA         73         DQa         DQb           24         DQPb         DQd         49         NC/SA*         74         DQPa         DQb	20	Vc	DQ	45	0	SA	70	VD	DQ	95		
23         DQb         DQd         48         SA         73         DQa         DQb           24         DQPb         DQd         49         NC/SA*         74         DQPa         DQb	21	V	ss	46	SA		71	V	'SS	96		
24 DQPb DQd 49 NC/SA* 74 DQPa DQb	22	DQb	DQd	47	0	SA	72	DQa	DQb	97		
	23	DQb	DQd	48		SA	73	DQa	DQb	98		
25 NC DQd 50 NC/SA* 75 NC DQb	24	DQPb	DQd	49	NC/SA*		74	DQPa	DQb	99		
	25	NC	DQd	50	NC	/SA*	75	NC	DQb	100		

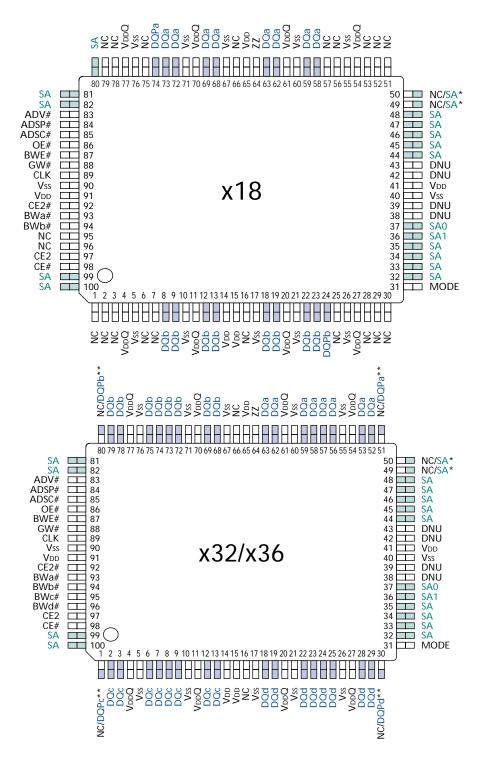
#### **TOFP PIN ASSIGNMENT TABLE**

\* Pins 49 and 50 are reserved for address expansion.

\*\* No Connect (NC) is used on the x32 version. Parity (DQPx) is used on the x36 version.



#### PIN ASSIGNMENT (Top View) 100-Pin TQFP



\* Pins 49 and 50 are reserved for address expansion.

\*\* No Connect (NC) is used on the x32 version. Parity (DQPx) is used on the x36 version.



## **TQFP PIN DESCRIPTIONS**

x18	x32/x36	SYMBOL	TYPE	DESCRIPTION
37 36 32-35, 44-48, 80-82, 99, 100	37 36 32-35, 44-48, 81, 82, 99, 100	SA0 SA1 SA	Input	Synchronous Address Inputs: These inputs are registered and must meet the setup and hold times around the rising edge of CLK.
93 94 - -	93 94 95 96	BWa# BWb# BWc# BWd#	Input	Synchronous Byte Write Enables: These active LOW inputs allow individual bytes to be written and must meet the setup and hold times around the rising edge of CLK. A byte write enable is LOW for a WRITE cycle and HIGH for a READ cycle. For the x18 version, BWa# controls DQa pins and DQPa; BWb# controls DQb pins and DQPb. For the x32 and x36 versions, BWa# controls DQa pins and DQPa; BWb# controls DQb pins and DQPb; BWc# controls DQc pins and DQPc; BWd# controls DQd pins and DQPd. Parity is only available on the x18 and x36 versions.
87	87	BWE#	Input	Byte Write Enable: This active LOW input permits BYTE WRITE operations and must meet the setup and hold times around the rising edge of CLK.
88	88	GW#	Input	Global Write: This active LOW input allows a full 18-, 32- or 36-bit WRITE to occur independent of the BWE# and BWx# lines and must meet the setup and hold times around the rising edge of CLK.
89	89	CLK	Input	Clock: This signal registers the address, data, chip enable, byte write enables and burst control inputs on its rising edge. All synchronous inputs must meet setup and hold times around the clock's rising edge.
98	98	CE#	Input	Synchronous Chip Enable: This active LOW input is used to enable the device and conditions the internal use of ADSP#. CE# is sampled only when a new external address is loaded.
92	92	CE2#	Input	Synchronous Chip Enable: This active LOW input is used to enable the device and is sampled only when a new external address is loaded.
97	97	CE2	Input	Synchronous Chip Enable: This active HIGH input is used to enable the device and is sampled only when a new external address is loaded.
86	86	OE#	Input	Output Enable: This active LOW, asynchronous input enables the data I/O output drivers.
83	83	ADV#	Input	Synchronous Address Advance: This active LOW input is used to advance the internal burst counter, controlling burst access after the external address is loaded. A HIGH on this pin effectively causes wait states to be generated (no address advance). To ensure use of correct address during a WRITE cycle, ADV# must be HIGH at the rising edge of the first clock after an ADSP# cycle is initiated.
84	84	ADSP#	Input	Synchronous Address Status Processor: This active LOW input interrupts any ongoing burst, causing a new external address to be registered. A READ is performed using the new address, independent of the byte write enables and ADSC#, but dependent upon CE#, CE2 and CE2#. ADSP# is ignored if CE# is HIGH. Power- down state is entered if CE2 is LOW or CE2# is HIGH.



# **TQFP PIN DESCRIPTIONS (continued)**

x18	x32/x36	SYMBOL	TYPE	DESCRIPTION
85	85	ADSC#	Input	Synchronous Address Status Controller: This active LOW input interrupts any ongoing burst, causing a new external address to be registered. A READ or WRITE is performed using the new address if CE# is LOW. ADSC# is also used to place the chip into power-down state when CE# is HIGH.
31	31	MODE	Input	Mode: This input selects the burst sequence. A LOW on this pin selects "linear burst." NC or HIGH on this pin selects "interleaved burst." Do not alter input state while device is operating.
64	64	ZZ	Input	Snooze Enable: This active HIGH, asynchronous input causes the device to enter a low-power standby mode in which all data in the memory array is retained. When ZZ is active, all other inputs are ignored.
(a) 58, 59, 62, 63, 68, 69, 72, 73 (b) 8, 9, 12, 13, 18, 19, 22, 23	<ul> <li>(a) 52, 53,</li> <li>56-59, 62, 63</li> <li>(b) 68, 69,</li> <li>72-75, 78, 79</li> </ul>	DQa DQb	Input/ Output	SRAM Data I/Os: For the x18 version, Byte "a" is DQa pins; Byte "b" is DQb pins. For the x32 and x36 versions, Byte "a" is DQa pins; Byte "b" is DQb pins; Byte "c" is DQc pins; Byte "d" is DQd pins. Input data must meet setup and hold times around the rising edge of CLK.
20	(c) 2, 3, 6-9, 12, 13 (d) 18, 19, 22-25, 28, 29	DQc DQd		
74 24 - -	51 80 1 30	NC/DQPa NC/DQPb NC/DQPc NC/DQPd	NC/ I/O	No Connect/Parity Data I/Os: On the x32 version, these pins are No Connect (NC). On the x18 version, Byte "a" parity is DQPa; Byte "b" parity is DQPb. On the x36 version, Byte "a" parity is DQPa; Byte "b" parity is DQPb; Byte "c" parity is DQPc; Byte "d" parity is DQPd.
14, 15, 41, 65, 91	14, 15, 41, 65, 91	Vdd	Supply	Power Supply: See DC Electrical Characteristics and Operating Conditions for range.
4, 11, 20, 27, 54, 61, 70, 77	4, 11, 20, 27, 54, 61, 70, 77	VddQ	Supply	Isolated Output Buffer Supply: See DC Electrical Characteristics and Operating Conditions for range.
5, 10, 17, 21, 26, 40, 55, 60, 67, 71, 76, 90	5, 10, 17, 21, 26, 40, 55, 60, 67, 71, 76, 90	Vss	Supply	Ground: GND.
38, 39, 42, 43	38, 39, 42, 43	DNU	-	Do Not Use: These signals may either be unconnected or wired to GND to improve package heat dissipation.
1-3, 6, 7, 16, 25, 28-30, 51-53, 56, 57, 66, 75, 78, 79, 95, 96	16, 66	NC	-	No Connect: These signals are not internally connected and may be connected to ground to improve package heat dissipation.
49, 50	49, 50	NC/SA	_	No Connect: These pins are reserved for address expansion.



# INTERLEAVED BURST ADDRESS TABLE (MODE = NC OR HIGH)

FIRST ADDRESS (EXTERNAL)	SECOND ADDRESS (INTERNAL)	THIRD ADDRESS (INTERNAL)	FOURTH ADDRESS (INTERNAL)
XX00	XX01	XX10	XX11
XX01	XX00	XX11	XX10
XX10	XX11	XX00	XX01
XX11	XX10	XX01	XX00

#### LINEAR BURST ADDRESS TABLE (MODE = LOW)

FIRST ADDRESS (EXTERNAL)	SECOND ADDRESS (INTERNAL)	THIRD ADDRESS (INTERNAL)	FOURTH ADDRESS (INTERNAL)
XX00	XX01	XX10	XX11
XX01	XX10	XX11	XX00
XX10	XX11	XX00	XX01
XX11	XX00	XX01	XX10

## PARTIAL TRUTH TABLE FOR WRITE COMMANDS (x18)

FUNCTION	GW#	BWE#	BWa#	BWb#
READ	Н	Н	Х	Х
READ	Н	L	Н	Н
WRITE Byte "a"	Н	L	L	Н
WRITE Byte "b"	Н	L	Н	L
WRITE All Bytes	Н	L	L	L
WRITE All Bytes	L	Х	Х	Х

## PARTIAL TRUTH TABLE FOR WRITE COMMANDS (x32/x36)

FUNCTION	GW#	BWE#	BWa#	BWb#	BWc#	BWd#
READ	Н	Н	Х	Х	Х	Х
READ	Н	L	Н	Н	Н	Н
WRITE Byte "a"	Н	L	L	Н	Н	Н
WRITE All Bytes	Н	L	L	L	L	L
WRITE All Bytes	L	Х	Х	Х	Х	Х

NOTE: Using BWE# and BWa# through BWd#, any one or more bytes may be written.



## TRUTH TABLE

OPERATION	ADDRESS USED	CE#	CE2#	CE2	ZZ	ADSP#	ADSC#	ADV#	WRITE#	OE#	CLK	DQ
Deselected Cycle, Power-Down	None	Н	Х	Х	L	Х	L	Х	Х	Х	L-H	High-Z
Deselected Cycle, Power-Down	None	L	Х	L	L	L	Х	Х	Х	Х	L-H	High-Z
Deselected Cycle, Power-Down	None	L	Н	Х	L	L	Х	Х	Х	Х	L-H	High-Z
Deselected Cycle, Power-Down	None	L	Х	L	L	Н	L	Х	Х	Х	L-H	High-Z
Deselected Cycle, Power-Down	None	L	Н	Х	L	Н	L	Х	Х	Х	L-H	High-Z
SNOOZE MODE, Power-Down	None	Х	Х	Х	Н	Х	Х	Х	Х	Х	Х	High-Z
READ Cycle, Begin Burst	External	L	L	Н	L	L	Х	Х	Х	L	L-H	Q
READ Cycle, Begin Burst	External	L	L	Н	L	L	Х	Х	Х	Н	L-H	High-Z
WRITE Cycle, Begin Burst	External	L	L	Н	L	Н	L	Х	L	Х	L-H	D
READ Cycle, Begin Burst	External	L	L	Н	L	Н	L	Х	Н	L	L-H	Q
READ Cycle, Begin Burst	External	L	L	Н	L	Н	L	Х	Н	Н	L-H	High-Z
READ Cycle, Continue Burst	Next	Х	Х	Х	L	Н	Н	L	Н	L	L-H	Q
READ Cycle, Continue Burst	Next	Х	Х	Х	L	Н	Н	L	Н	Н	L-H	High-Z
READ Cycle, Continue Burst	Next	Н	Х	Х	L	Х	Н	L	Н	L	L-H	Q
READ Cycle, Continue Burst	Next	Н	Х	Х	L	Х	Н	L	Н	Н	L-H	High-Z
WRITE Cycle, Continue Burst	Next	Х	Х	Х	L	Н	Н	L	L	Х	L-H	D
WRITE Cycle, Continue Burst	Next	Н	Х	Х	L	Х	Н	L	L	Х	L-H	D
READ Cycle, Suspend Burst	Current	Х	Х	Х	L	Н	Н	Н	Н	L	L-H	Q
READ Cycle, Suspend Burst	Current	Х	Х	Х	L	Н	Н	Н	Н	Н	L-H	High-Z
READ Cycle, Suspend Burst	Current	Н	Х	Х	L	Х	Н	Н	Н	L	L-H	Q
READ Cycle, Suspend Burst	Current	Н	Х	Х	L	Х	Н	Н	Н	Н	L-H	High-Z
WRITE Cycle, Suspend Burst	Current	Х	Х	Х	L	Н	Н	Н	L	Х	L-H	D
WRITE Cycle, Suspend Burst	Current	Н	Х	Х	L	Х	Н	Н	L	Х	L-H	D

NOTE: 1. X means "Don't Care." # means active LOW. H means logic HIGH. L means logic LOW.

2. For WRITE#, L means any one or more byte write enable signals (BWa#, BWb#, BWc# or BWd#) and BWE# are LOW or GW# is LOW. WRITE# = H for all BWx#, BWE#, GW# HIGH.

3. BWa# enables WRITEs to DQa pins, DQPa. BWb# enables WRITEs to DQb pins, DQPb. BWc# enables WRITEs to DQc pins, DQPc. BWd# enables WRITEs to DQd pins, DQPd. DQPa and DQPb are only available on the x18 and x36 versions. DQPc and DQPd are only available on the x36 version.

- 4. All inputs except OE# and ZZ must meet setup and hold times around the rising edge (LOW to HIGH) of CLK.
- 5. Wait states are inserted by suspending burst.

6. For a WRITE operation following a READ operation, OE# must be HIGH before the input data setup time and held HIGH throughout the input data hold time.

7. This device contains circuitry that will ensure the outputs will be in High-Z during power-up.

8. ADSP# LOW always initiates an internal READ at the L-H edge of CLK. A WRITE is performed by setting one or more byte write enable signals and BWE# LOW or GW# LOW for the subsequent L-H edge of CLK. Refer to WRITE timing diagram for clarification.



#### **ABSOLUTE MAXIMUM RATINGS\***

 \*Stresses greater than those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress rating only, and functional operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect reliability.

\*\*Maximum junction temperature depends upon package type, cycle time, loading, ambient temperature and airflow. See Micron Technical Note TN-05-14 for more information.

#### DC ELECTRICAL CHARACTERISTICS AND OPERATING CONDITIONS

 $(0^{\circ}C \le T_A \le +70^{\circ}C; V_{DD}, V_{DD}Q = +3.3V + 0.3V/-0.165V unless otherwise noted)$ 

DESCRIPTION	CONDITIONS	SYMBOL	MIN	MAX	UNITS	NOTES
Input High (Logic 1) Voltage		Vін	2.0	VDD + 0.3	V	1, 2
Input Low (Logic 0) Voltage		VIL	-0.3	0.8	V	1, 2
Input Leakage Current	$0V \le V$ IN $\le V$ DD	ILi	-1.0	1.0	μA	3
Output Leakage Current	Output(s) disabled, $OV \le V_{IN} \le V_{DD}$	ILo	-1.0	1.0	μA	
Output High Voltage	Iон = -4.0mA	Vон	2.4	-	V	1, 4
Output Low Voltage	IoL = 8.0mA	Vol	-	0.4	V	1, 4
Supply Voltage		Vdd	3.135	3.6	V	1
Isolated Output Buffer Supply		VddQ	3.135	Vdd	V	1, 5

- NOTE: 1. All voltages referenced to Vss (GND).
  - $\begin{array}{lll} \text{2. Overshoot:} & \text{ViH} \leq +4.6 \text{V for } t \leq {}^{t}\text{KC}/2 \text{ for } l \leq 20\text{mA} \\ \text{Undershoot:} & \text{ViL} \geq -0.7 \text{V for } t \leq {}^{t}\text{KC}/2 \text{ for } l \leq 20\text{mA} \\ \text{Power-up:} & \text{ViH} \leq +3.6 \text{V and } \text{V}\text{DD} \leq 3.135 \text{V for } t \leq 200\text{ms} \\ \end{array}$
  - 3. MODE pin has an internal pull-up, and input leakage =  $\pm 10\mu$ A.
  - 4. The load used for VOH, VOL testing is shown in Figure 2. AC load current is higher than the shown DC values. AC I/O curves are available upon request.
  - 5. VDDQ should never exceed VDD. VDD and VDDQ can be connected together.



#### IDD OPERATING CONDITIONS AND MAXIMUM LIMITS

(0°C  $\leq$  T<sub>A</sub>  $\leq$  +70°C; VDD, VDDQ = +3.3V +0.3V/-0.165V unless otherwise noted)

					MAX			
DESCRIPTION	CONDITIONS	SYMBOL	TYP	-6	-7.5	-10	UNITS	NOTES
Power Supply Current: Operating	Device selected; All inputs ≤ VIL or ≥ VIH; Cycle time ≥ <sup>t</sup> KC MIN; VDD = MAX; Outputs open	Idd	100	340	280	225	mA	1, 2, 3
Power Supply Current: Idle	Device selected; $V_{DD} = MAX$ ; ADSC#, ADSP#, GW#, BWx#, ADV# $\geq$ VIH; All inputs $\leq$ Vss + 0.2 or $\geq$ VDD - 0.2; Cycle time $\geq$ <sup>t</sup> KC MIN	Idd1	30	85	70	65	mA	1, 2, 3
CMOS Standby	Device deselected; $V_{DD} = MAX$ ; All inputs $\leq V_{SS} + 0.2$ or $\geq V_{DD} - 0.2$ ; All inputs static; CLK frequency = 0	Isb2	0.5	10	10	10	mA	2, 3
TTL Standby	Device deselected; VDD = MAX; All inputs ≤ VIL or ≥ VIH; All inputs static; CLK frequency = 0	Isb3	6	25	25	25	mA	2, 3
Clock Running	Device deselected; $V_{DD} = MAX$ ; ADSC#, ADSP#, GW#, BWx#, ADV# $\geq$ VIH; All inputs $\leq V_{SS} + 0.2$ or $\geq V_{DD} - 0.2$ ; Cycle time $\geq {}^{t}KC$ MIN	Isb4	30	85	70	65	mA	2, 3

#### CAPACITANCE

DESCRIPTION	CONDITIONS	SYMBOL	ТҮР	MAX	UNITS	NOTES
Control Input Capacitance	T <sub>A</sub> = 25°C; f = 1 MHz;	Сі	2.7	3.5	рF	4
Input/Output Capacitance (DQ)	$V_{DD} = 3.3V$	Со	4	5	pF	4
Address Capacitance		Са	2.5	3.5	pF	4
Clock Capacitance		Сск	2.5	3.5	рF	4

## **TQFP THERMAL RESISTANCE**

DESCRIPTION	CONDITIONS	SYMBOL	ТҮР	UNITS	NOTES
Thermal Resistance (Junction to Ambient)	Test conditions follow standard test methods and procedures for measuring thermal	$\theta_{JA}$	40	°C/W	4
Thermal Resistance (Junction to Top of Case)	impedance, per EIA/JESD51.	$\theta_{JC}$	8	°C/W	4

**NOTE:** 1. IDD is specified with no output current and increases with faster cycle times. IDDQ increases with faster cycle times and greater output loading.

- 2. "Device deselected" means device is in power-down mode as defined in the truth table. "Device selected" means device is active (not in power-down mode).
- 3. Typical values are measured at 3.3V, 25°C and 10ns cycle time.
- 4. This parameter is sampled.



## ELECTRICAL CHARACTERISTICS AND RECOMMENDED AC OPERATING CONDITIONS

(Note 1) ( $0^{\circ}C \le T_{A} \le +70^{\circ}C$ ; VDD, VDDQ = +3.3V +0.3V/-0.165V)

		-	6	-7	<b>7</b> .5	-10			
DESCRIPTION	SYMBOL	MIN	MAX	MIN	MAX	MIN	MAX		NOTES
Clock			•		•				
Clock cycle time	<sup>t</sup> KC	6.0		7.5		10		ns	
Clock frequency	<sup>f</sup> KF		166		133		100	MHz	
Clock HIGH time	<sup>t</sup> KH	1.7		1.9		3.2		ns	2
Clock LOW time	<sup>t</sup> KL	1.7		1.9		3.2		ns	2
Output Times									
Clock to output valid	<sup>t</sup> KQ		3.5		4.2		5.0	ns	
Clock to output invalid	<sup>t</sup> KQX	1.5		1.5		1.5		ns	3
Clock to output in Low-Z	<sup>t</sup> KQLZ	1.5		1.5		1.5		ns	3, 4, 5, 6
Clock to output in High-Z	<sup>t</sup> KQHZ		3.5		4.2		5.0	ns	3, 4, 5, 6
OE# to output valid	<sup>t</sup> OEQ		3.5		4.2		5.0	ns	7
OE# to output in Low-Z	tOELZ	0		0		0		ns	3, 4, 5, 6
OE# to output in High-Z	<sup>t</sup> OEHZ		3.5		4.2		4.5	ns	3, 4, 5, 6
Setup Times									
Address	<sup>t</sup> AS	1.7		2.0		2.2		ns	8, 9
Address status (ADSC#, ADSP#)	<sup>t</sup> ADSS	1.7		2.0		2.2		ns	8, 9
Address advance (ADV#)	<sup>t</sup> AAS	1.7		2.0		2.2		ns	8, 9
Write signals (BWa#-BWd#, BWE#, GW#)	tWS	1.7		2.0		2.2		ns	8, 9
Data-in	<sup>t</sup> DS	1.7		2.0		2.2		ns	8, 9
Chip enables (CE#, CE2#, CE2)	<sup>t</sup> CES	1.7		2.0		2.2		ns	8, 9
Hold Times			•		•		•		
Address	<sup>t</sup> AH	0.5		0.5		0.5		ns	8, 9
Address status (ADSC#, ADSP#)	<sup>t</sup> ADSH	0.5		0.5		0.5		ns	8, 9
Address advance (ADV#)	<sup>t</sup> AAH	0.5		0.5		0.5		ns	8, 9
Write signals (BWa#-BWd#, BWE#, GW#)	tWH	0.5		0.5		0.5		ns	8, 9
Data-in	<sup>t</sup> DH	0.5		0.5		0.5		ns	8, 9
Chip enables (CE#, CE2#, CE2)	<sup>t</sup> CEH	0.5		0.5		0.5		ns	8, 9

NOTE: 1. Test conditions as specified with the output loading shown in Figure 1 unless otherwise noted.

2. Measured as HIGH above VIH and LOW below VIL.

3. This parameter is measured with the output loading shown in Figure 2.

4. This parameter is sampled.

5. Transition is measured  $\pm$ 500mV from steady state voltage.

- 6. Refer to Technical Note TN-58-09, "Synchronous SRAM Bus Contention Design Considerations," for a more thorough discussion on these parameters.
- 7. OE# is a "Don't Care" when a byte write enable is sampled LOW.
- 8. A WRITE cycle is defined by at least one byte write enable LOW and ADSP# HIGH for the required setup and hold times. A READ cycle is defined by all byte write enables HIGH and ADSC# or ADV# LOW or ADSP# LOW for the required setup and hold times.
- 9. This is a synchronous device. All addresses must meet the specified setup and hold times for all rising edges of CLK when either ADSP# or ADSC# is LOW and chip enabled. All other synchronous inputs must meet the setup and hold times with stable logic levels for all rising edges of clock (CLK) when the chip is enabled. Chip enable must be valid at each rising edge of CLK when either ADSP# or ADSC# is LOW to remain enabled.



# AC TEST CONDITIONS

Input pulse levels VIH = (VDD/2.2) + 1.5V
VIL = (VDD/2.2) - 1.5V
Input rise and fall times 1ns
Input timing reference levels VDD/2.2
Output reference levelsVDDQ/2.2
Output load See Figures 1 and 2

#### **Output Load Equivalent**

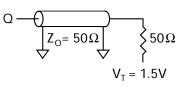
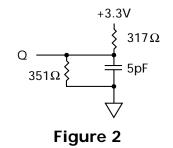


Figure 1

#### LOAD DERATING CURVES

Micron 64K x 18, 32K x 32, or 32K x 36 SyncBurst SRAM timing is dependent upon the capacitive loading on the outputs.

Consult the factory for copies of I/O current versus voltage curves.





#### **SNOOZE MODE**

SNOOZE MODE is a low-current, "power-down" mode in which the device is deselected and current is reduced to Isb2z. The duration of SNOOZE MODE is dictated by the length of time the ZZ pin is in a HIGH state. After the device enters SNOOZE MODE, all inputs except ZZ become gated inputs and are ignored.

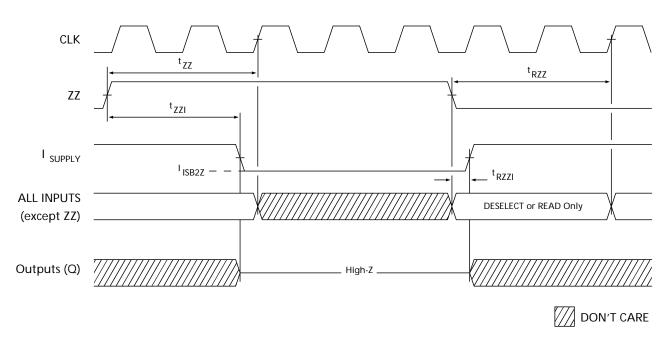
The ZZ pin is an asynchronous, active HIGH input that causes the device to enter SNOOZE MODE. When the ZZ pin becomes a logic HIGH, ISB2z is guaranteed after the setup time <sup>t</sup>ZZ is met. Any READ or WRITE operation pending when the device enters SNOOZE MODE is not guaranteed to complete successfully. Therefore, SNOOZE MODE must not be initiated until valid pending operations are completed.

#### SNOOZE MODE ELECTRICAL CHARACTERISTICS

DESCRIPTION	CONDITIONS	SYMBOL	MIN	MAX	UNITS	NOTES
Current during SNOOZE MODE	$ZZ \ge V_{IH}$	Isb2z		10	mA	
ZZ active to input ignored		<sup>t</sup> ZZ		2( <sup>t</sup> KC)	ns	1
ZZ inactive to input sampled		<sup>t</sup> RZZ	2( <sup>t</sup> KC)		ns	1
ZZ active to snooze current		tZZI		2( <sup>t</sup> KC)	ns	1
ZZ inactive to exit snooze current		<sup>t</sup> RZZI	0		ns	1

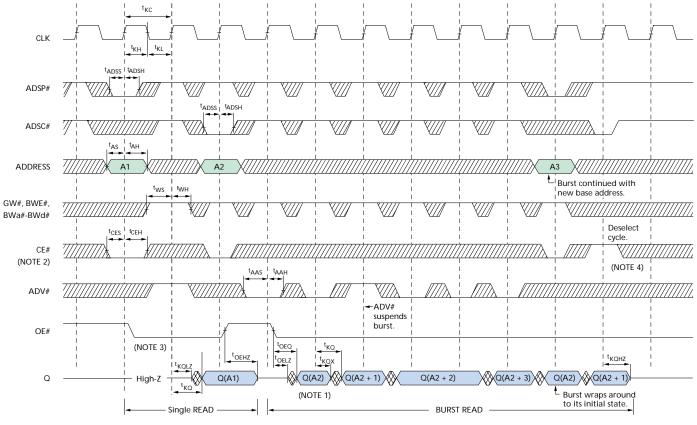
**NOTE:** 1. This parameter is sampled.

#### SNOOZE MODE WAVEFORM





**READ TIMING** 



DON'T CARE WUNDEFINED

#### **READ TIMING PARAMETERS**

	-	6	-7	.5	-10		
SYM	MIN	MAX	MIN	MAX	MIN	MAX	UNITS
<sup>t</sup> KC	6.0		7.5		10		ns
<sup>f</sup> KF		166		133		100	MHz
<sup>t</sup> KH	1.7		1.9		3.2		ns
<sup>t</sup> KL	1.7		1.9		3.2		ns
<sup>t</sup> KQ		3.5		4.2		5.0	ns
<sup>t</sup> KQX	1.5		1.5		1.5		ns
<sup>t</sup> KQLZ	1.5		1.5		1.5		ns
<sup>t</sup> KQHZ		3.5		4.2		5.0	ns
<sup>t</sup> OEQ		3.5		4.2		5.0	ns
<sup>t</sup> OELZ	0		0		0		ns
<sup>t</sup> OEHZ		3.5		4.2		4.5	ns

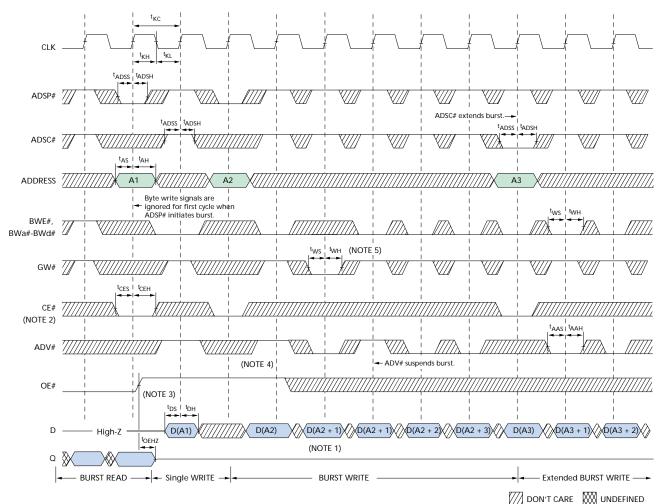
	-6		-7.5		-1		
SYM	MIN	MAX	MIN	MAX	MIN	MAX	UNITS
<sup>t</sup> AS	1.7		2.0		2.2		ns
<sup>t</sup> ADSS	1.7		2.0		2.2		ns
<sup>t</sup> AAS	1.7		2.0		2.2		ns
tWS	1.7		2.0		2.2		ns
<sup>t</sup> CES	1.7		2.0		2.2		ns
<sup>t</sup> AH	0.5		0.5		0.5		ns
<sup>t</sup> ADSH	0.5		0.5		0.5		ns
<sup>t</sup> AAH	0.5		0.5		0.5		ns
<sup>t</sup> WH	0.5		0.5		0.5		ns
<sup>t</sup> CEH	0.5		0.5		0.5		ns

**NOTE:** 1. Q(A2) refers to output from address A2. Q(A2 + 1) refers to output from the next internal burst address following A2. 2. CE2# and CE2 have timing identical to CE#. On this diagram, when CE# is LOW, CE2# is LOW and CE2 is HIGH. When

- CE# is HIGH, CE2# is HIGH and CE2 is LOW.
  3. Timing is shown assuming that the device was not enabled before entering into this sequence. OE# does not cause Q to be driven until after the following clock rising edge.
- 4. Outputs are disabled within one clock cycle after deselect.



WRITE TIMING



#### WRITE TIMING PARAMETERS

-6		-6 -7.5		-1			
SYM	MIN	MAX	MIN	MAX	MIN	MAX	UNITS
<sup>t</sup> KC	6.0		7.5		10		ns
<sup>f</sup> KF		166		133		100	MHz
<sup>t</sup> KH	1.7		1.9		3.2		ns
<sup>t</sup> KL	1.7		1.9		3.2		ns
tOEHZ		3.5		4.2		4.5	ns
<sup>t</sup> AS	1.7		2.0		2.2		ns
<sup>t</sup> ADSS	1.7		2.0		2.2		ns
<sup>t</sup> AAS	1.7		2.0		2.2		ns
<sup>t</sup> WS	1.7		2.0		2.2		ns

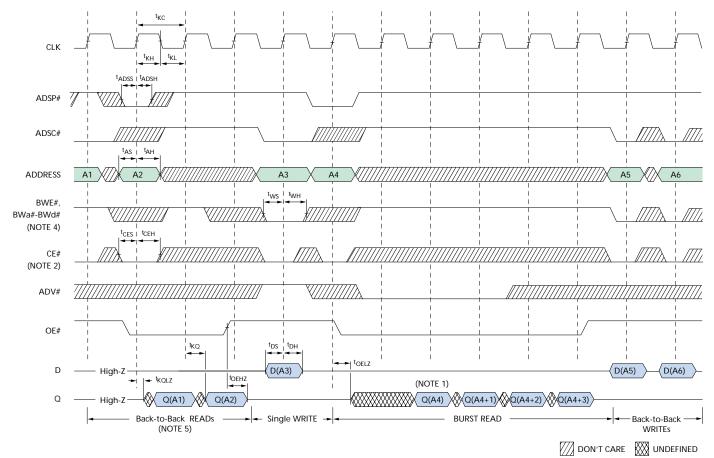
	-	6	-7.5		-1		
SYM	MIN	MAX	MIN	MAX	MIN	MAX	UNITS
<sup>t</sup> DS	1.7		2.0		2.2		ns
<sup>t</sup> CES	1.7		2.0		2.2		ns
<sup>t</sup> AH	0.5		0.5		0.5		ns
<sup>t</sup> ADSH	0.5		0.5		0.5		ns
<sup>t</sup> AAH	0.5		0.5		0.5		ns
<sup>t</sup> WH	0.5		0.5		0.5		ns
<sup>t</sup> DH	0.5		0.5		0.5		ns
<sup>t</sup> CEH	0.5		0.5		0.5		ns

**NOTE:** 1. D(A2) refers to input for address A2. Q(A2 + 1) refers to input for the next internal burst address following A2.

- 2. CE2# and CE2 have timing identical to CE#. On this diagram, when CE# is LOW, CE2# is LOW and CE2 is HIGH. When CE# is HIGH, CE2# is HIGH and CE2 is LOW.
  - 3. OE# must be HIGH before the input data setup and held HIGH throughout the data hold time. This prevents input/output data contention for the time period prior to the byte write enable inputs being sampled.
  - 4. ADV# must be HIGH to permit a WRITE to the loaded address.
- 5. Full-width WRITE can be initiated by GW# LOW; or GW# HIGH and BWE#, BWa# and BWb# LOW for x18 device; or GW# HIGH and BWE#, BWa#-BWd# LOW for x32 and x36 devices.



**READ/WRITE TIMING** 



#### READ/WRITE TIMING PARAMETERS

	-	6	-7	.5	-10		
SYMBO	_ MIN	MAX	MIN	MAX	MIN	MAX	UNITS
<sup>t</sup> KC	6.0		7.5		10		ns
<sup>f</sup> KF		166		133		100	MHz
<sup>t</sup> KH	1.7		1.9		3.2		ns
<sup>t</sup> KL	1.7		1.9		3.2		ns
<sup>t</sup> KQ		3.5		4.2		5.0	ns
<sup>t</sup> KQLZ	1.5		1.5		1.5		ns
tOELZ	0		0		0		ns
<sup>t</sup> OEHZ		3.5		4.2		4.5	ns
<sup>t</sup> AS	1.7		2.0		2.2		ns

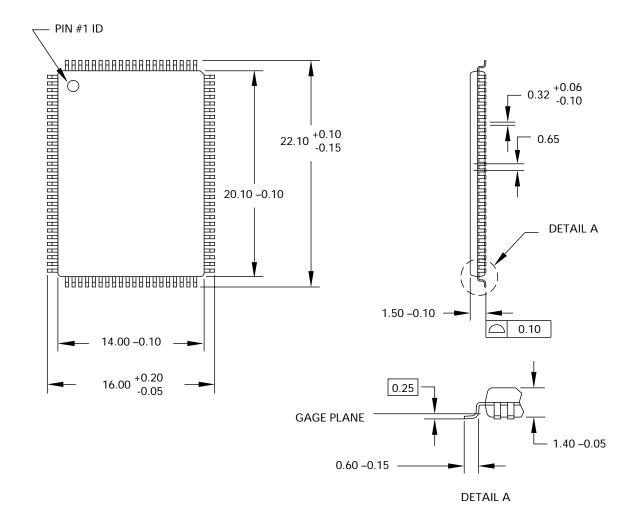
	-6		-7.5		-1		
SYMBO	. MIN	MAX	MIN	MAX	MIN	MAX	UNITS
<sup>t</sup> ADSS	1.7		2.0		2.2		ns
<sup>t</sup> WS	1.7		2.0		2.2		ns
<sup>t</sup> DS	1.7		2.0		2.2		ns
<sup>t</sup> CES	1.7		2.0		2.2		ns
<sup>t</sup> AH	0.5		0.5		0.5		ns
<sup>t</sup> ADSH	0.5		0.5		0.5		ns
<sup>t</sup> WH	0.5		0.5		0.5		ns
<sup>t</sup> DH	0.5		0.5		0.5		ns
<sup>t</sup> CEH	0.5		0.5		0.5		ns

**NOTE:** 1. Q(A4) refers to output from address A4. Q(A4 + 1) refers to output from the next internal burst address following A4. 2. CE2# and CE2 have timing identical to CE#. On this diagram, when CE# is LOW, CE2# is LOW and CE2 is HIGH. When

- CE# is HIGH, CE2# is HIGH and CE2 is LOW.
- 3. The data bus (Q) remains in High-Z following a WRITE cycle unless an ADSP#, ADSC# or ADV# cycle is performed.
- 4. GW# is HIGH.
- 5. Back-to-back READs may be controlled by either ADSP# or ADSC#.



# **100-PIN PLASTIC TQFP (JEDEC LQFP)**



**NOTE:** 1. All dimensions in millimeters <u>MAX</u> or typical where noted.

2. Package width and length do not include mold protrusion; allowable mold protrusion is .01" per side.



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